

Ordering number : ENA0518



SANYO Semiconductors

DATA SHEET

N-Channel Silicon MOSFET

FSS804 — General-Purpose Switching Device Applications

Features

- Low ON-resistance.
- 4V drive.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	V _{DSS}		30	V
Gate-to-Source Voltage	V _{GSS}		±20	V
Drain Current (DC)	I _D		14	A
Drain Current (PW≤10s)	I _D	Duty cycle≤1%	18	A
Drain Current (PW≤10μs)	I _{DP}	Duty cycle≤1%	52	A
Allowable Power Dissipation	P _D	Mounted on a ceramic board (1200mm²X0.8mm), PW≤10s	3.3	W
Channel Temperature	T _{ch}		150	°C
Storage Temperature	T _{stg}		-55 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	I _D =1mA, V _{GS} =0V	30			V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V			1	μA
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} =±16V, V _{DS} =0V			±10	μA
Cutoff Voltage	V _{GS(off)}	V _{DS} =10V, I _D =1mA	1.2		2.6	V
Forward Transfer Admittance	y _{fs}	V _{DS} =10V, I _D =14A	11.5	19		S
Static Drain-to-Source On-State Resistance	R _{DS(on)1}	I _D =14A, V _{GS} =10V		7	10	mΩ
	R _{DS(on)2}	I _D =7A, V _{GS} =4.5V		11	16	mΩ
	R _{DS(on)3}	I _D =7A, V _{GS} =4V		14	20	mΩ
Input Capacitance	C _{iss}	V _{DS} =10V, f=1MHz		3000		pF
Output Capacitance	C _{oss}	V _{DS} =10V, f=1MHz		500		pF
Reverse Transfer Capacitance	C _{rss}	V _{DS} =10V, f=1MHz		350		pF
Turn-ON Delay Time	t _{d(on)}	See specified Test Circuit.		28		ns
Rise Time	t _r	See specified Test Circuit.		250		ns
Turn-OFF Delay Time	t _{d(off)}	See specified Test Circuit.		160		ns
Fall Time	t _f	See specified Test Circuit.		120		ns

Marking : S804

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FSS804

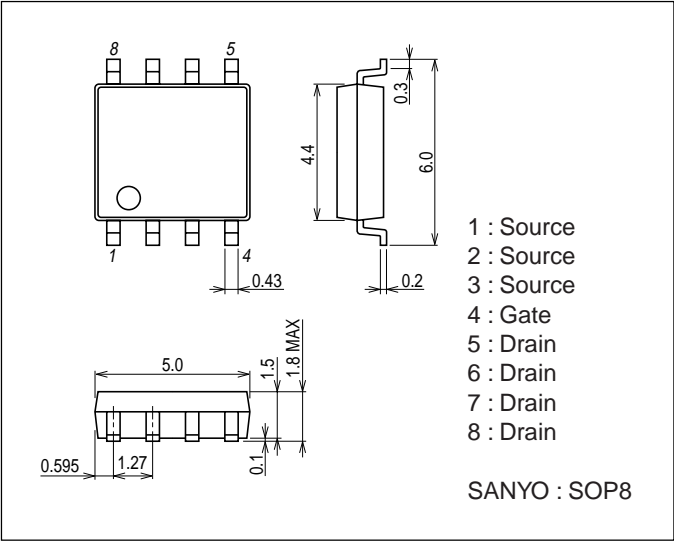
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Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Total Gate Charge	Qg	V _{DS} =10V, V _{GS} =10V, I _D =14A		50		nC
Gate-to-Source Charge	Qgs	V _{DS} =10V, V _{GS} =10V, I _D =14A		8		nC
Gate-to-Drain "Miller" Charge	Qgd	V _{DS} =10V, V _{GS} =10V, I _D =14A		10		nC
Diode Forward Voltage	V _{SD}	I _S =14A, V _{GS} =0V		0.81	1.2	V

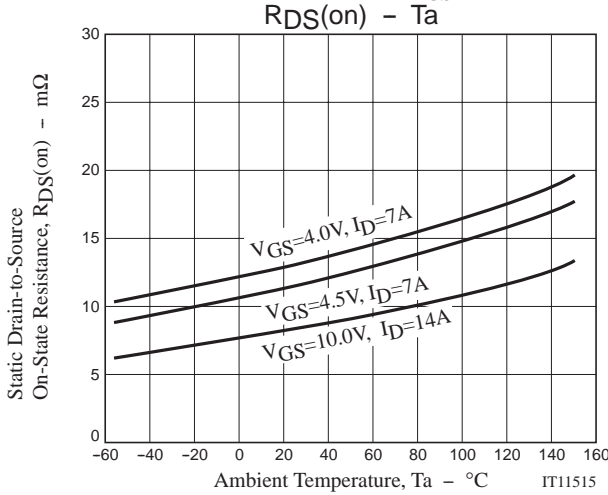
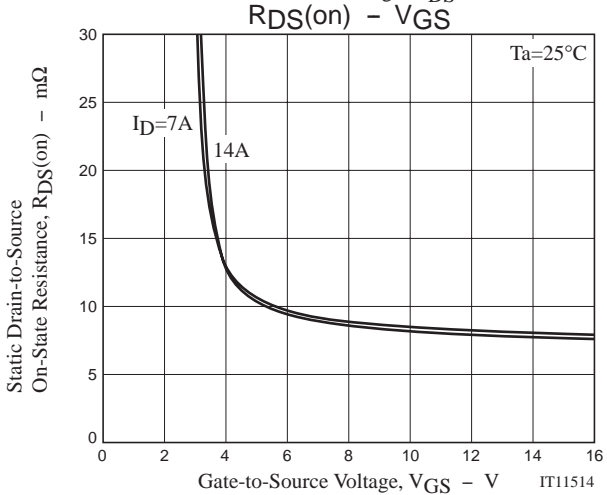
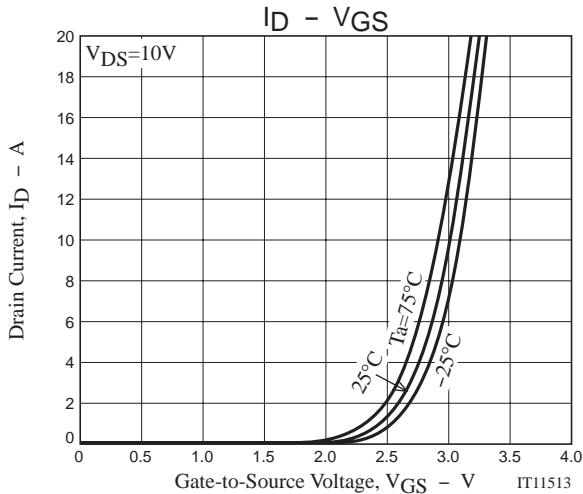
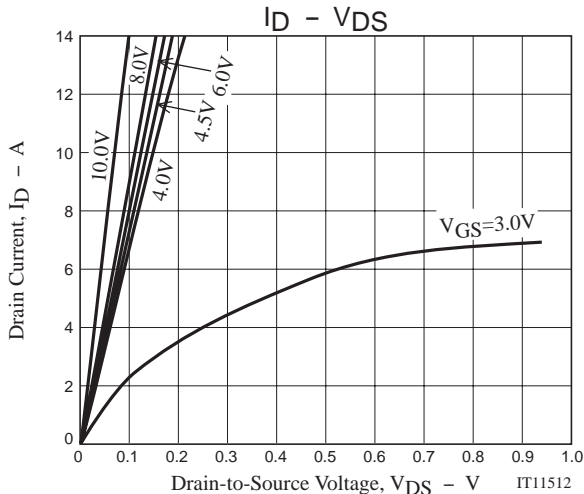
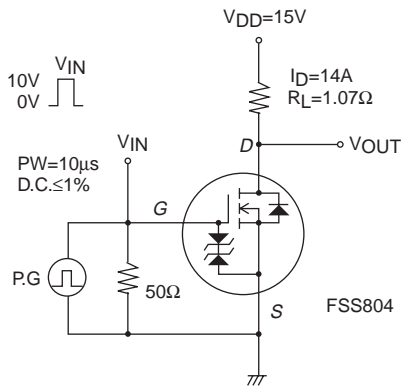
Package Dimensions

unit : mm (typ)

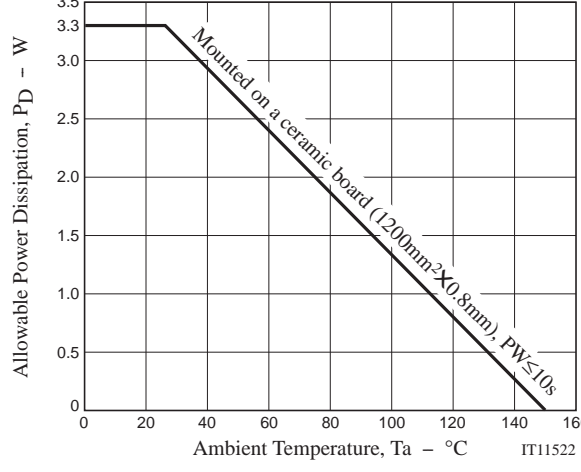
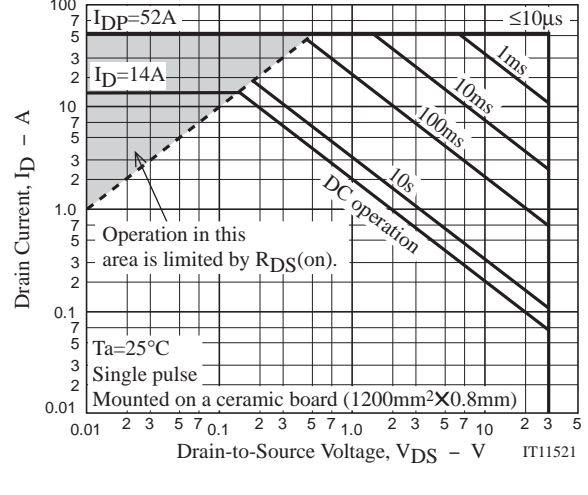
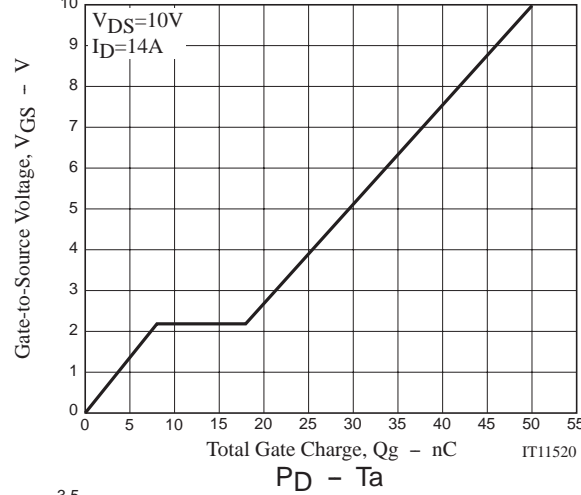
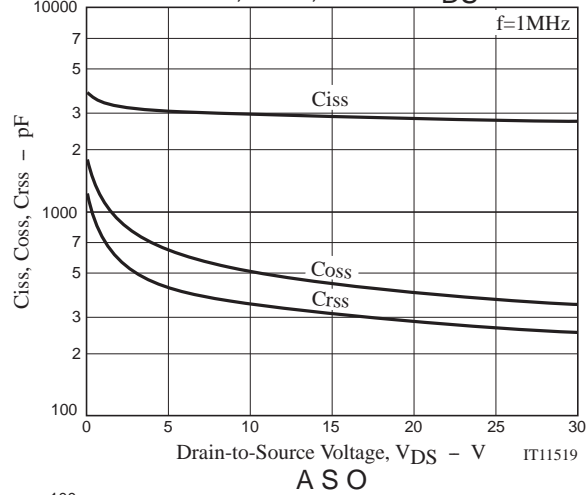
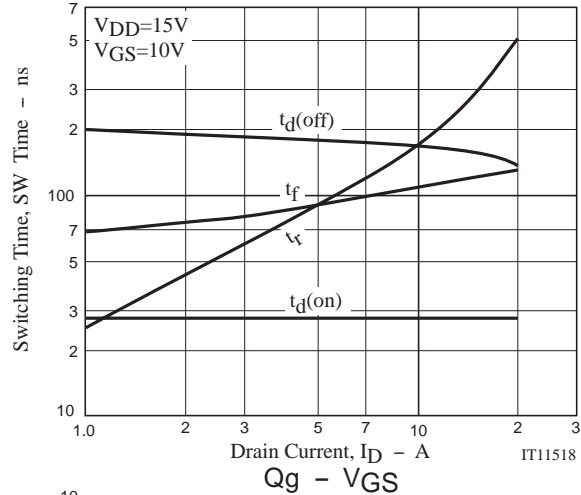
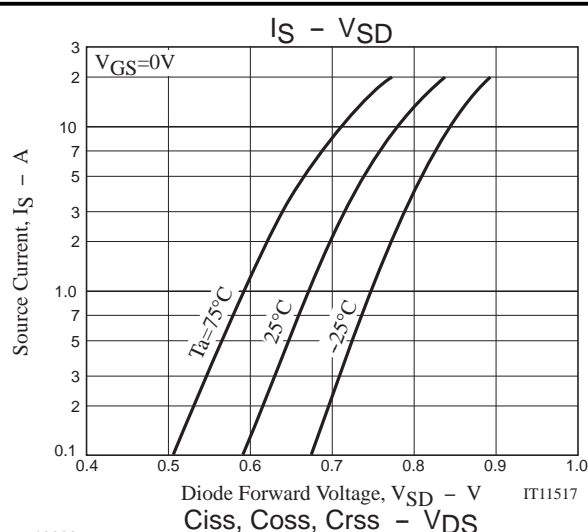
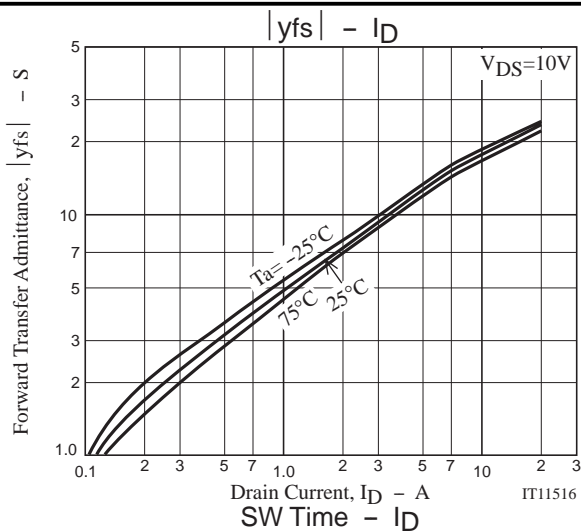
7005-002



Switching Time Test Circuit



FSS804



Note on usage : Since the FSS804 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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